Search Notes



Application/Control No.	Applicant(s)/Patent Under Reexamination
10661225	NGUYEN ET AL.
Examiner	Art Unit
Nguyen, Hiep	2816

SEARCHED						
Class	Subclass	Date	Examiner			
327	175, 18, 20, 26	01-25-07	Hn			

SEARCH NOTES					
Search Notes	Date	Examiner			
EAST	01-25-07	Hn			

INTERFERENCE SEARCH						
Class	Subclass	Date	Examiner			